Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/903,901	LEON, DAVID
Examiner	Art Unit

2665

Steven HD Nguyen

SEARCHED					
	<u> </u>				
Class	Subclass	Date	Examiner		
370	252, 351- 356	6/16/2005	v		
	503-510				
	516-519				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

(INCLUDING SEARCH	STRATEGY)
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